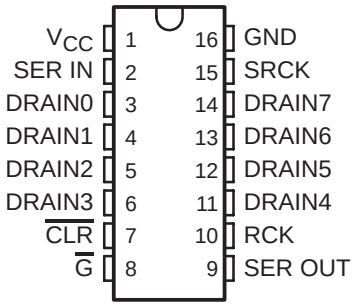
- **Low $r_{DS(on)}$ . . . 7 Ω Typ**
- **Avalanche Energy . . . 30 mJ**
- **Eight Power DMOS Transistor Outputs of 100-mA Continuous Current**
- **250-mA Current Limit Capability**
- **ESD Protection . . . 2500 V**
- **Output Clamp Voltage . . . 33 V**
- **Devices Are Cascadable**
- **Low Power Consumption**

D, N, OR PW PACKAGE
(TOP VIEW)

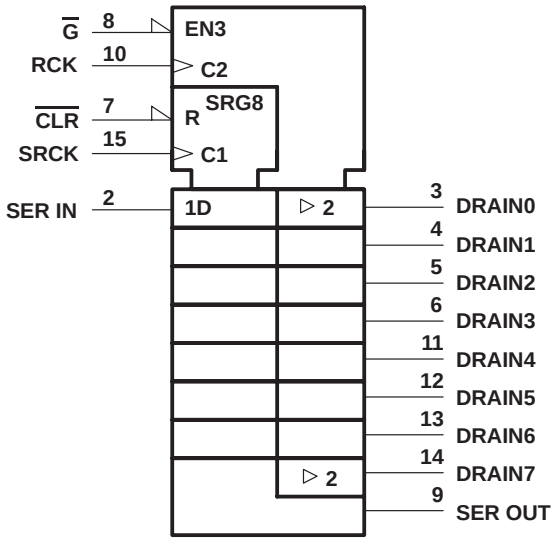


description

The TPIC6C595 is a monolithic, medium-voltage, low-current power 8-bit shift register designed for use in systems that require relatively moderate load power such as LEDs. The device contains a built-in voltage clamp on the outputs for inductive transient protection. Power driver applications include relays, solenoids, and other low-current or medium-voltage loads.

This device contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Data transfers through both the shift and storage registers on the rising edge of the shift register clock (SRCK) and the register clock (RCK), respectively. The device transfers data out the serial output (SER OUT) port on the rising edge of SRCK. The storage register transfers data to the output buffer when shift register clear ($\overline{CLR}$) is high. When $\overline{CLR}$ is low, the input shift register is cleared. When output enable ($\overline{G}$) is held high, all data in the output buffers is held low and all drain outputs are off. When $\overline{G}$ is held low, data from the storage register is transparent to the output buffers. When data in the output buffers is low, the DMOS transistor outputs are off. When data is high, the DMOS transistor outputs have sink-current capability. The SER OUT allows for cascading of the data from the shift register to additional devices.

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

This device contains circuits to protect its inputs and outputs against damage due to high static voltages or electrostatic fields. These circuits have been qualified to protect this device against electrostatic discharges (ESD) of up to 2 kV according to MIL-STD-883C, Method 3015; however, it is advised that precautions be taken to avoid application of any voltage higher than maximum-rated voltages to these high-impedance circuits. During storage or handling, the device leads should be shorted together or the device should be placed in conductive foam. In a circuit, unused inputs should always be connected to an appropriated logic voltage level, preferably either V_{CC} or ground. Specific guidelines for handling devices of this type are contained in the publication *Guidelines for Handling Electrostatic-Discharge-Sensitive (ESDS) Devices and Assemblies* available from Texas Instruments.

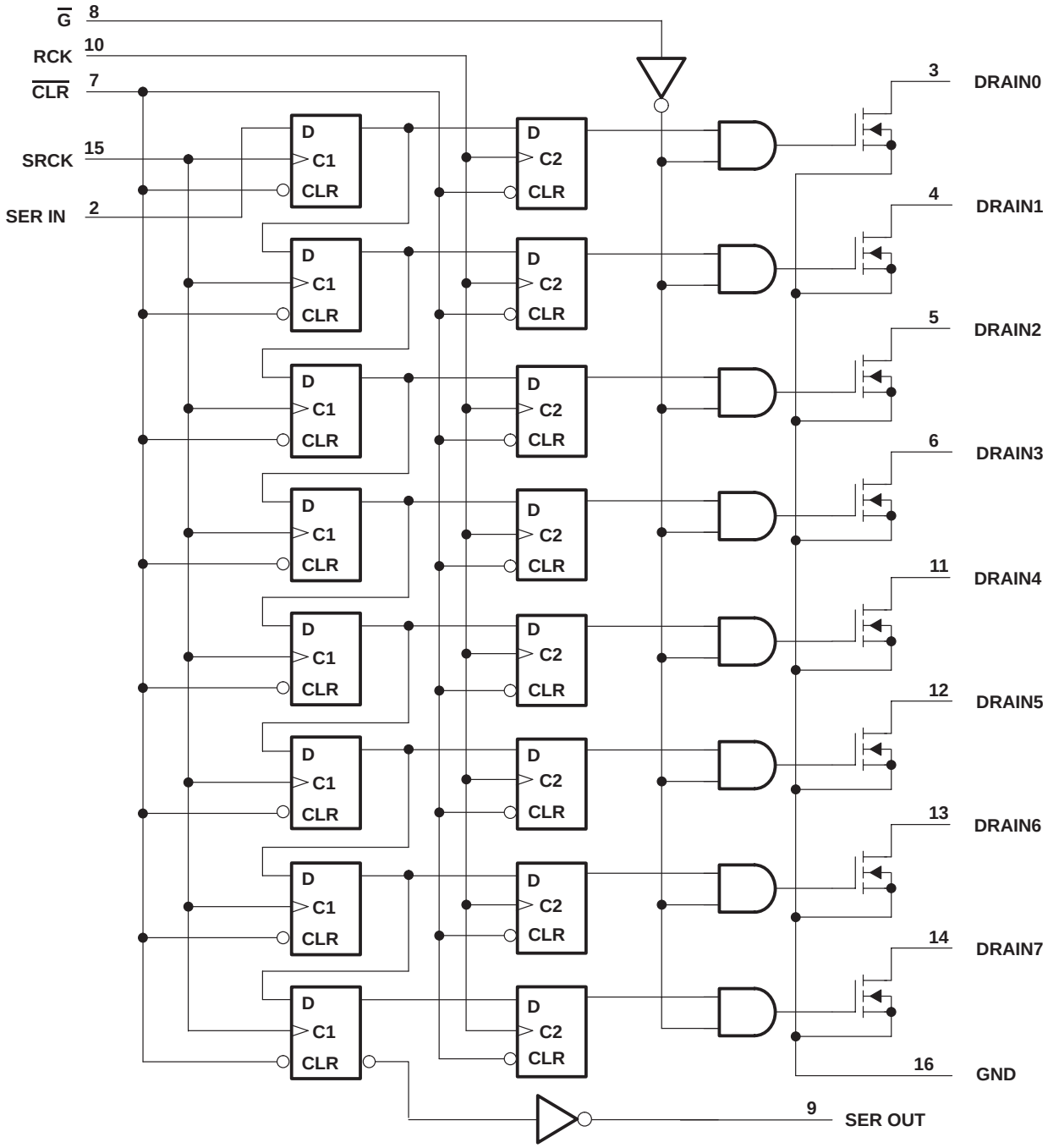
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

description (continued)

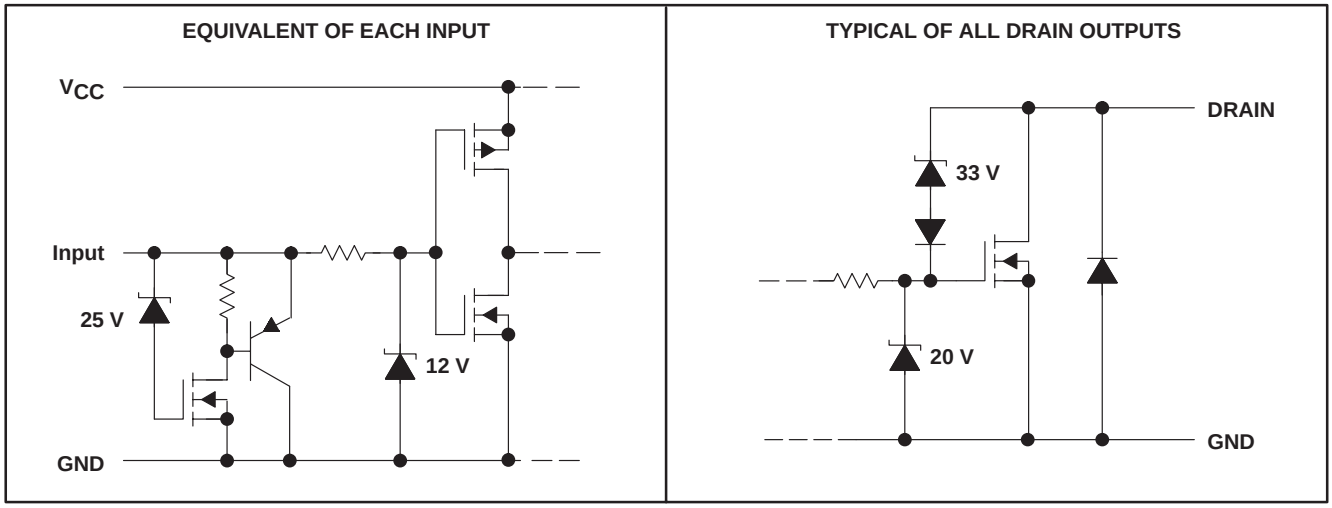
Outputs are low-side, open-drain DMOS transistors with output ratings of 33 V and 100 mA continuous sink-current capability. Each output provides a 250-mA maximum current limit at T_C = 25°C. The current limit decreases as the junction temperature increases for additional device protection. The device also provides up to 2500 V of ESD protection when tested using the human-body model and the 200-V machine model.

The TPIC6C595 is characterized for operation over the operating case temperature range of −40°C to 125°C.

logic diagram (positive logic)



schematic of inputs and outputs



absolute maximum ratings over recommended operating case temperature range (unless otherwise noted)†

Logic supply voltage, V_{CC} (see Note 1)	7 V
Logic input voltage range, V_I	−0.3 V to 7 V
Power DMOS drain-to-source voltage, V_{DS} (see Note 2)	33 V
Continuous source-to-drain diode anode current	250 mA
Pulsed source-to-drain diode anode current (see Note 3)	500 mA
Pulsed drain current, each output, all outputs on, I_D, T_C = 25°C (see Note 3)	250 mA
Continuous drain current, each output, all outputs on, I_D, T_C = 25°C	100 mA
Peak drain current single output, I_{DM}, T_C = 25°C (see Note 3)	250 mA
Single-pulse avalanche energy, E_{AS} (see Figure 4)	30 mJ
Avalanche current, I_{AS} (see Note 4)	200 mA
Continuous total dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T_J	−40°C to 150°C
Operating case temperature range, T_C	−40°C to 125°C
Storage temperature range, T_{stg}	−65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to GND.
2. Each power DMOS source is internally connected to GND.
3. Pulse duration ≤ 100 µs and duty cycle ≤ 2%.
4. DRAIN supply voltage = 15 V, starting junction temperature (T_{JS}) = 25°C, L = 1.5 H, I_{AS} = 200 mA (see Figure 4).

DISSIPATION RATING TABLE

PACKAGE	$T_C \le 25°C$ POWER RATING	DERATING FACTOR ABOVE T_C = 25°C	T_C = 125°C POWER RATING
D	1087 mW	8.7 mW/°C	217 mW
N	1470 mW	11.7 mW/°C	294 mW
PW	1372 mW	10.976 mW/°C	274 mW

recommended operating conditions

	MIN	MAX	UNIT
Logic supply voltage, V_{CC}	4.5	5.5	V
High-level input voltage, V_{IH}	0.85 V_{CC}		V
Low-level input voltage, V_{IL}		0.15 V_{CC}	V
Pulsed drain output current, T_C = 25°C, V_{CC} = 5 V, all outputs on (see Notes 3 and 5 and Figure 11)		250	mA
Setup time, SER IN high before SRCK↑, t_{su} (see Figure 2)	20		ns
Hold time, SER IN high after SRCK↑, t_h (see Figure 2)	20		ns
Pulse duration, t_w (see Figure 2)	40		ns
Operating case temperature, T_C	−40	125	°C

electrical characteristics, V_{CC} = 5 V, T_C = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$V_{(BR)DSX}$	Drain-to-source breakdown voltage	I_D = 1 mA		33	37		V
V_{SD}	Source-to-drain diode forward voltage	I_F = 100 mA			0.85	1.2	V
V_{OH}	High-level output voltage, SER OUT	I_{OH} = −20 µA,	V_{CC} = 4.5 V	4.4	4.49		V
		I_{OH} = −4 mA,	V_{CC} = 4.5 V	4	4.2		
V_{OL}	Low-level output voltage, SER OUT	I_{OL} = 20 µA,	V_{CC} = 4.5 V		0.005	0.1	V
		I_{OL} = 4 mA,	V_{CC} = 4.5 V		0.3	0.5	
I_{IH}	High-level input current	V_{CC} = 5.5 V,	V_I = V_{CC}			1	µA
I_{IL}	Low-level input current	V_{CC} = 5.5 V,	V_I = 0			−1	µA
I_{CC}	Logic supply current	V_{CC} = 5.5 V	All outputs off		20	200	µA
			All outputs on		150	500	
$I_{CC(FRQ)}$	Logic supply current at frequency	f_{SRCK} = 5 MHz, All outputs off,	C_L = 30 pF, See Figures 2 and 6		1.2	5	mA
I_N	Nominal current	$V_{DS(on)}$ = 0.5 V, T_C = 85°C,	I_N = I_D, See Notes 5, 6, and 7		90		mA
I_{DSX}	Off-state drain current	V_{DS} = 30 V,	V_{CC} = 5.5 V		0.1	0.2	µA
		V_{DS} = 30 V, T_C = 125°C	V_{CC} = 5.5 V,		0.15	0.3	
$r_{DS(on)}$	Static drain-source on-state resistance	I_D = 50 mA, V_{CC} = 4.5 V	See Notes 5 and 6 and Figures 7 and 8		6.5	9	Ω
		I_D = 50 mA, T_C = 125°C, V_{CC} = 4.5 V			9.9	12	
		I_D = 100 mA, V_{CC} = 4.5 V			6.8	10	

NOTES: 3. Pulse duration ≤ 100 µs and duty cycle ≤ 2%.
5. Technique should limit $T_J - T_C$ to 10°C maximum.
6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.
7. Nominal current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at T_C = 85°C.

switching characteristics, V_{CC} = 5 V, T_C = 25°C

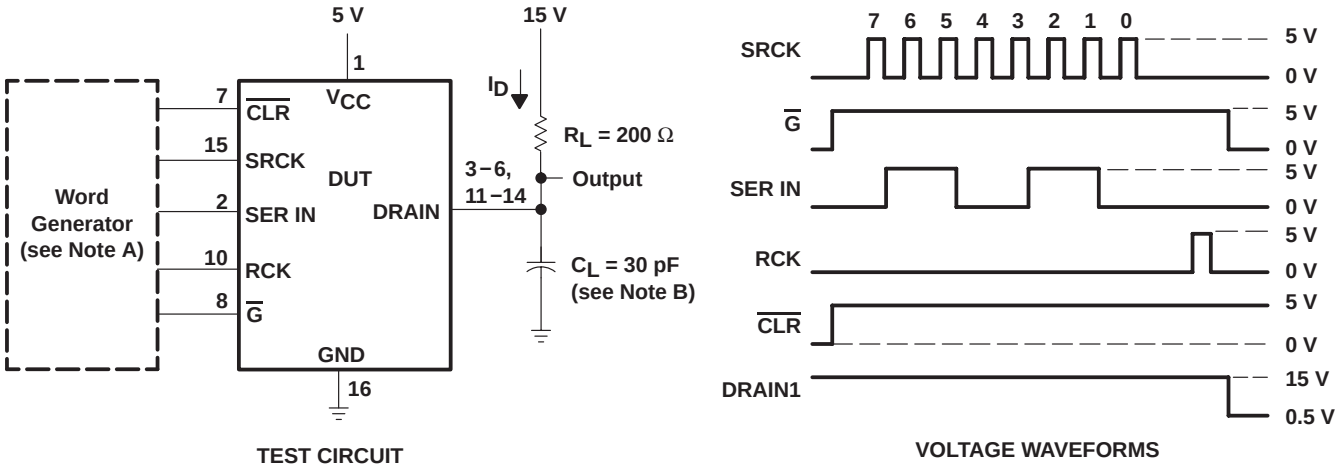
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Propagation delay time, low-to-high-level output from $\overline{G}$	C_L = 30 pF, I_D = 75 mA, See Figures 1, 2, and 9		80		ns
t_{PHL}	Propagation delay time, high-to-low-level output from $\overline{G}$			50		ns
tpd	Propagation delay time, SRCK to SEROUT			20		ns
t_r	Rise time, drain output			100		ns
t_f	Fall time, drain output			80		ns
t_a	Reverse-recovery-current rise time	I_F = 100 mA, di/dt = 10 A/µs, See Notes 5 and 6 and Figure 3		100		ns
t_{rr}	Reverse-recovery time			120		

NOTES: 5. Technique should limit $T_J - T_C$ to 10°C maximum.
6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

thermal resistance

PARAMETER			TEST CONDITIONS	MIN	MAX	UNIT
$R_{\theta JA}$	Thermal resistance, junction-to-ambient	D package	All 8 outputs with equal power		115	°C/W
		N package			85	
		PW package			108	

PARAMETER MEASUREMENT INFORMATION

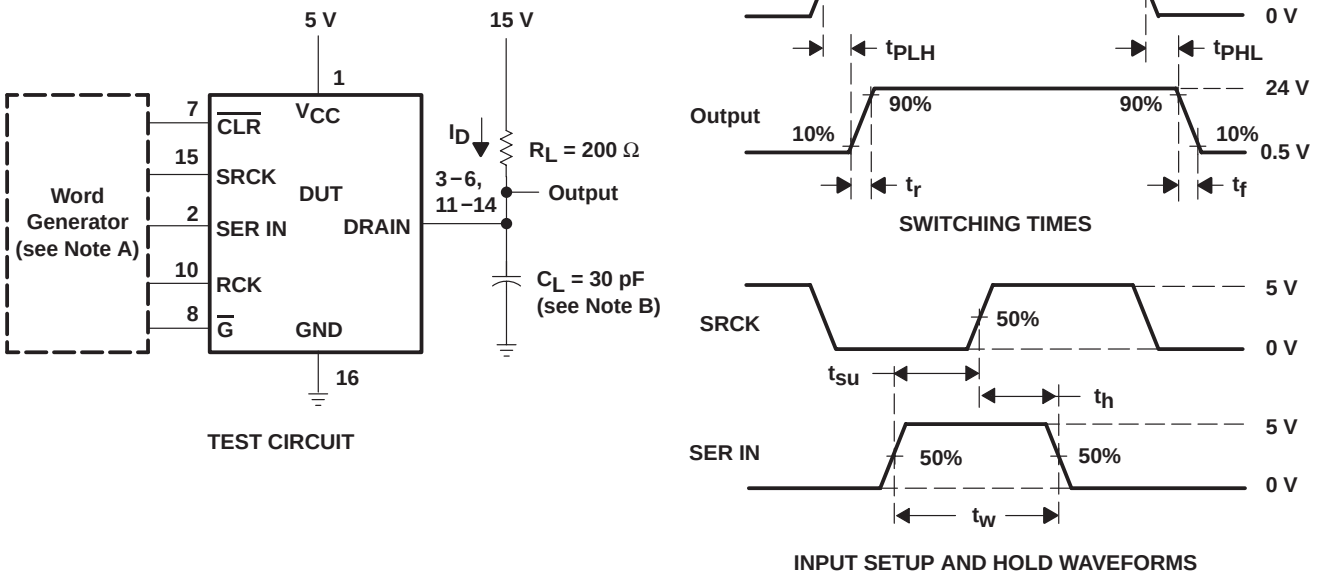


TEST CIRCUIT VOLTAGE WAVEFORMS

NOTES: A. The word generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, t_w = 300 ns, pulsed repetition rate (PRR) = 5 kHz, Z_O = 50 Ω.
B. C_L includes probe and jig capacitance.

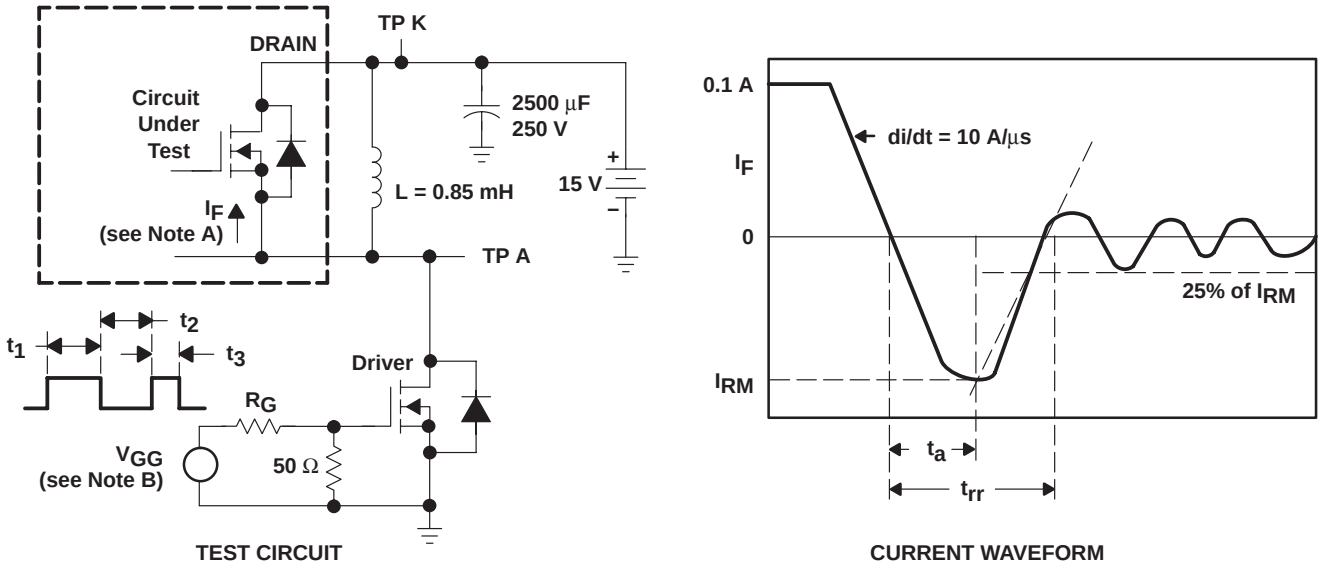
Figure 1. Resistive-Load Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The word generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $t_W = 300$ ns, pulsed repetition rate (PRR) = 5 kHz, $Z_O = 50\ \Omega$.
B. C_L includes probe and jig capacitance.

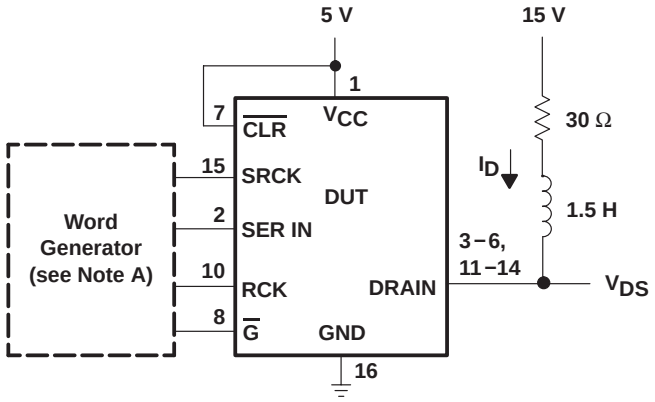
Figure 2. Test Circuit, Switching Times, and Voltage Waveforms



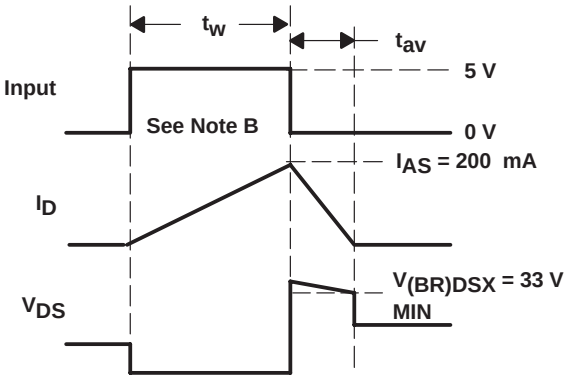
NOTES: A. The DRAIN terminal under test is connected to the TP K test point. All other terminals are connected together and connected to the TP A test point.
B. The V_{GG} amplitude and R_G are adjusted for di/dt = 10 A/μs. A V_{GG} double-pulse train is used to set $I_F = 0.1$ A, where $t_1 = 10$ μs, $t_2 = 7$ μs, and $t_3 = 3$ μs.

Figure 3. Reverse-Recovery-Current Test Circuit and Waveforms of Source-to-Drain Diode

PARAMETER MEASUREMENT INFORMATION



SINGLE-PULSE AVALANCHE ENERGY TEST CIRCUIT



VOLTAGE AND CURRENT WAVEFORMS

NOTES: A. The word generator has the following characteristics: $t_r \le 10$ ns, $t_f \le 10$ ns, $Z_O = 50\ \Omega$.
B. Input pulse duration, t_w, is increased until peak current $I_{AS} = 200$ mA.
Energy test level is defined as $E_{AS} = I_{AS} \times V_{(BR)DSX} \times t_{av}/2 = 30$ mJ.

Figure 4. Single-Pulse Avalanche Energy Test Circuit and Waveforms

TYPICAL CHARACTERISTICS

PEAK AVALANCHE CURRENT vs TIME DURATION OF AVALANCHE

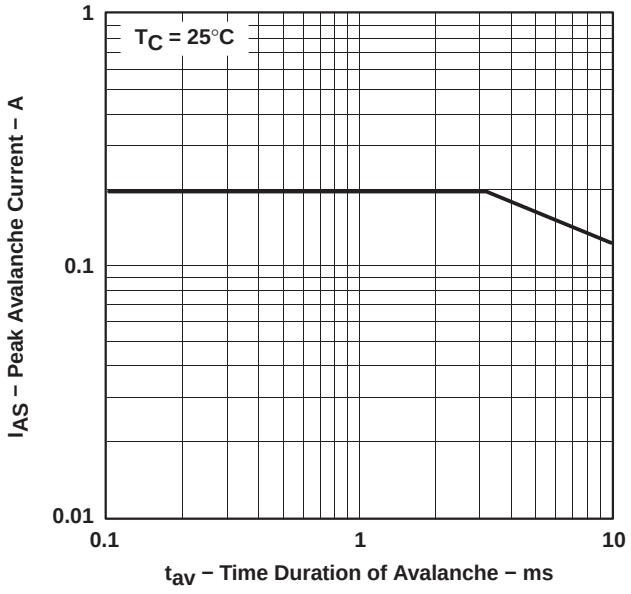


Figure 5

SUPPLY CURRENT vs FREQUENCY

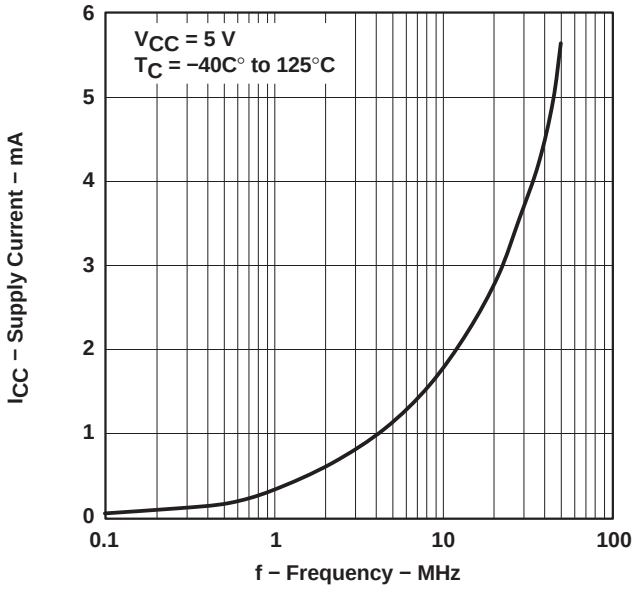


Figure 6

TYPICAL CHARACTERISTICS

DRAIN-TO-SOURCE ON-STATE RESISTANCE vs DRAIN CURRENT

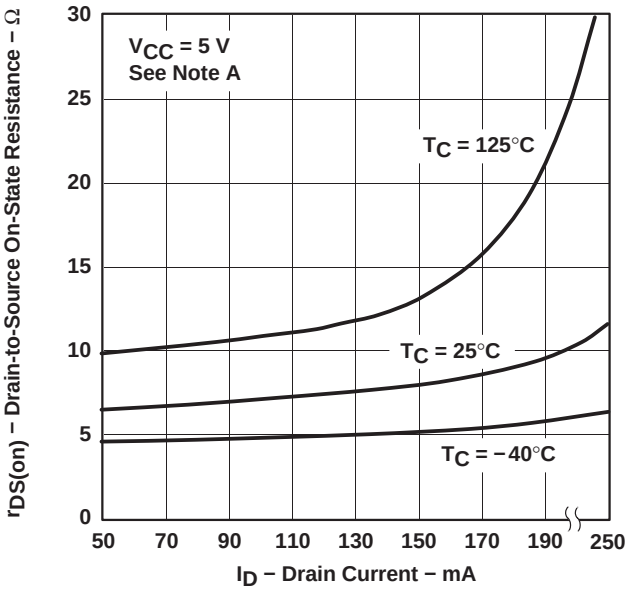


Figure 7

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE vs LOGIC SUPPLY VOLTAGE

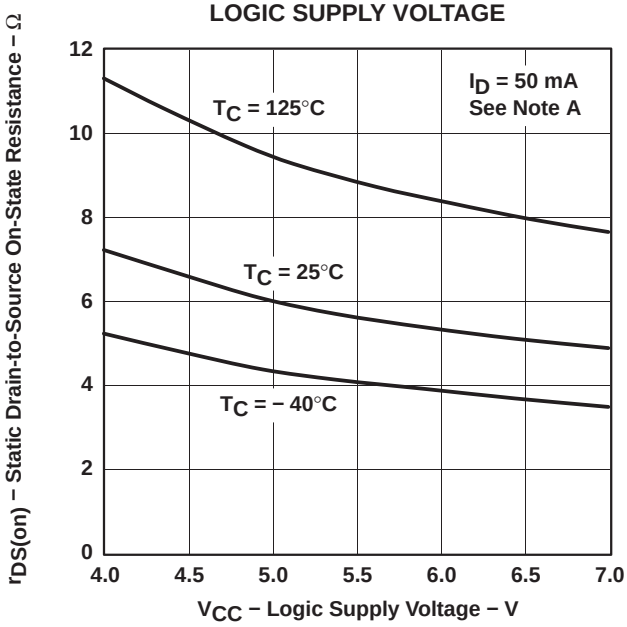


Figure 8

SWITCHING TIME vs CASE TEMPERATURE

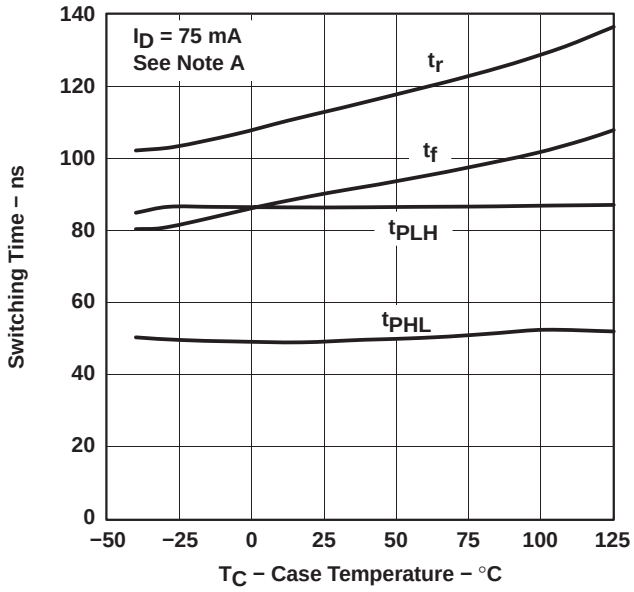


Figure 9

NOTE A: Technique should limit $T_J - T_C$ to 10°C maximum.

THERMAL INFORMATION

MAXIMUM CONTINUOUS DRAIN CURRENT OF EACH OUTPUT vs NUMBER OF OUTPUTS CONDUCTING SIMULTANEOUSLY

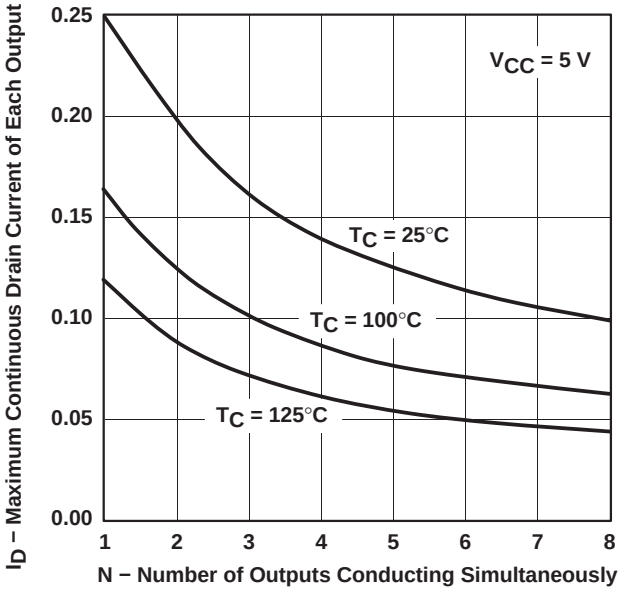


Figure 10

MAXIMUM PEAK DRAIN CURRENT OF EACH OUTPUT vs NUMBER OF OUTPUTS CONDUCTING SIMULTANEOUSLY

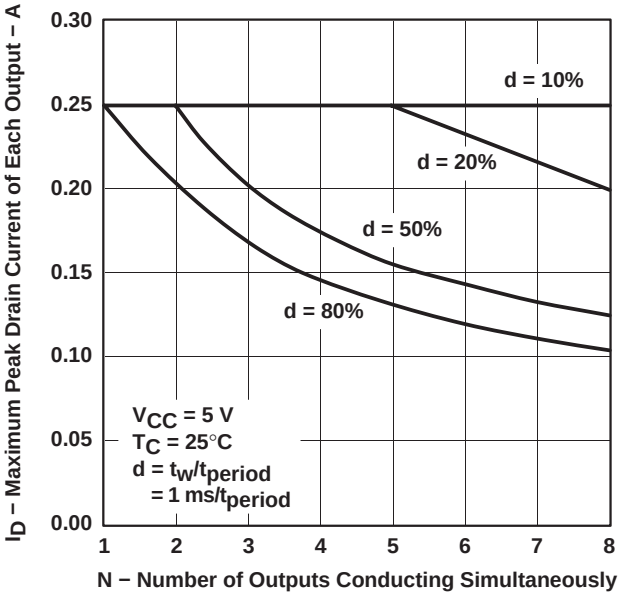
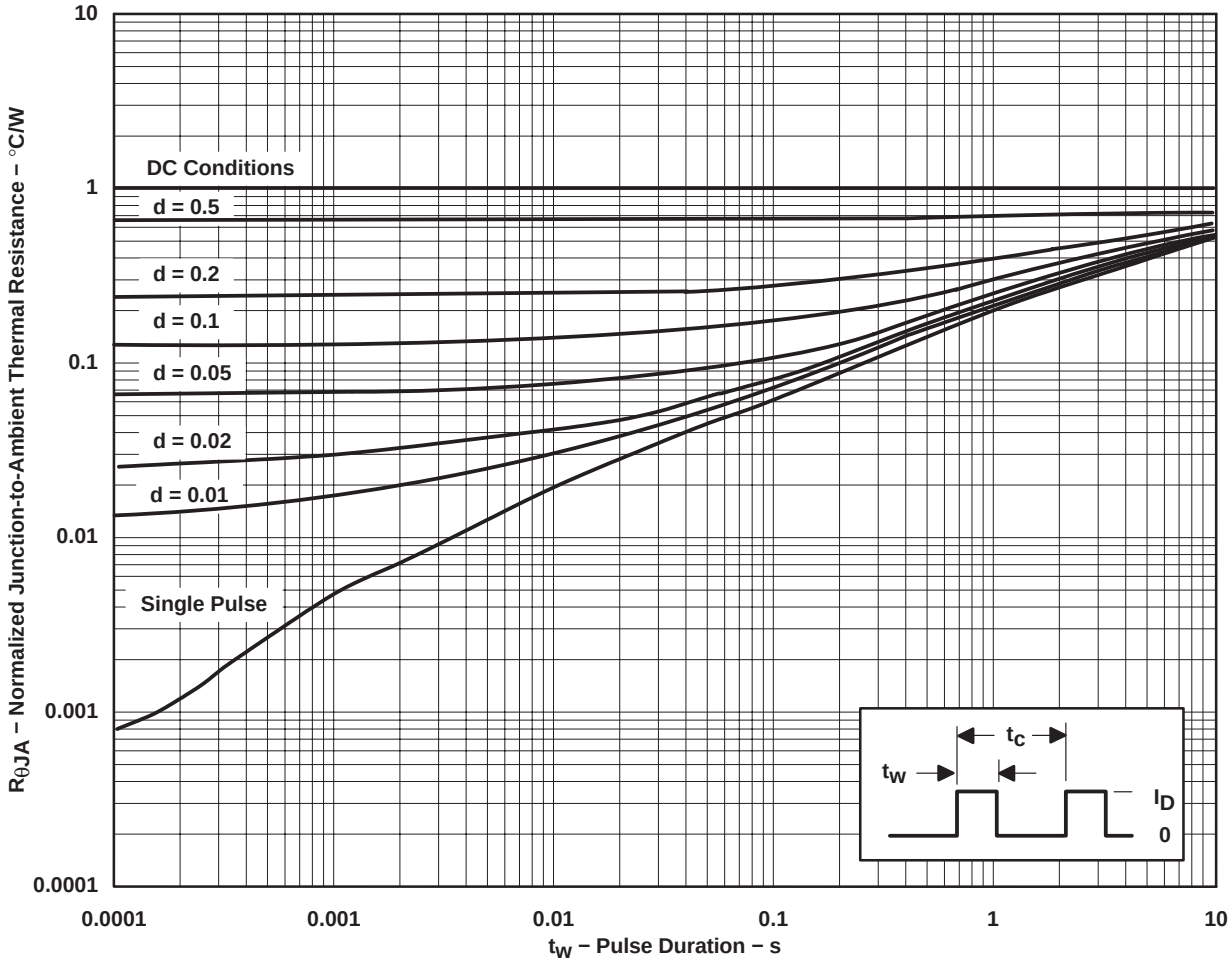


Figure 11

THERMAL INFORMATION

D PACKAGE†
NORMALIZED JUNCTION-TO-AMBIENT THERMAL RESISTANCE
vs
PULSE DURATION



† Device mounted on FR4 printed-circuit board with no heat sink

NOTES: $Z_{\theta A}(t) = r(t)\ R_{\theta JA}$
t_W = pulse duration
t_C = cycle time
d = duty cycle = t_W/t_C

Figure 12

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)
TPIC6C595D	ACTIVE	SOIC	D	16	40	TBD	CU NIPDAU	Level-1-220C-UNLIM
TPIC6C595DG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TPIC6C595DR	ACTIVE	SOIC	D	16	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
TPIC6C595DRG4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TPIC6C595N	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
TPIC6C595PW	ACTIVE	TSSOP	PW	16	90	TBD	CU NIPDAU	Level-1-220C-UNLIM
TPIC6C595PWR	ACTIVE	TSSOP	PW	16	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

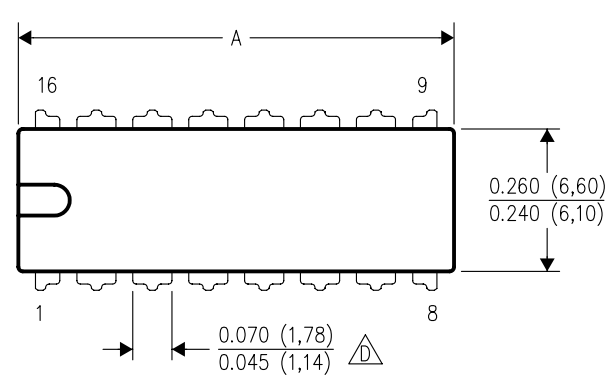
(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

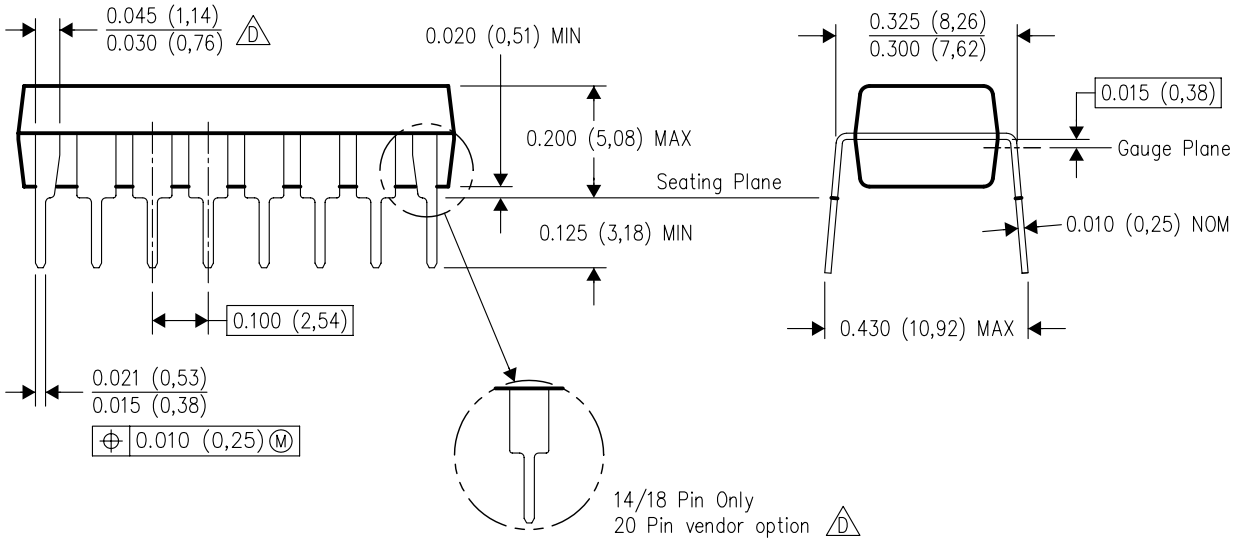
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN



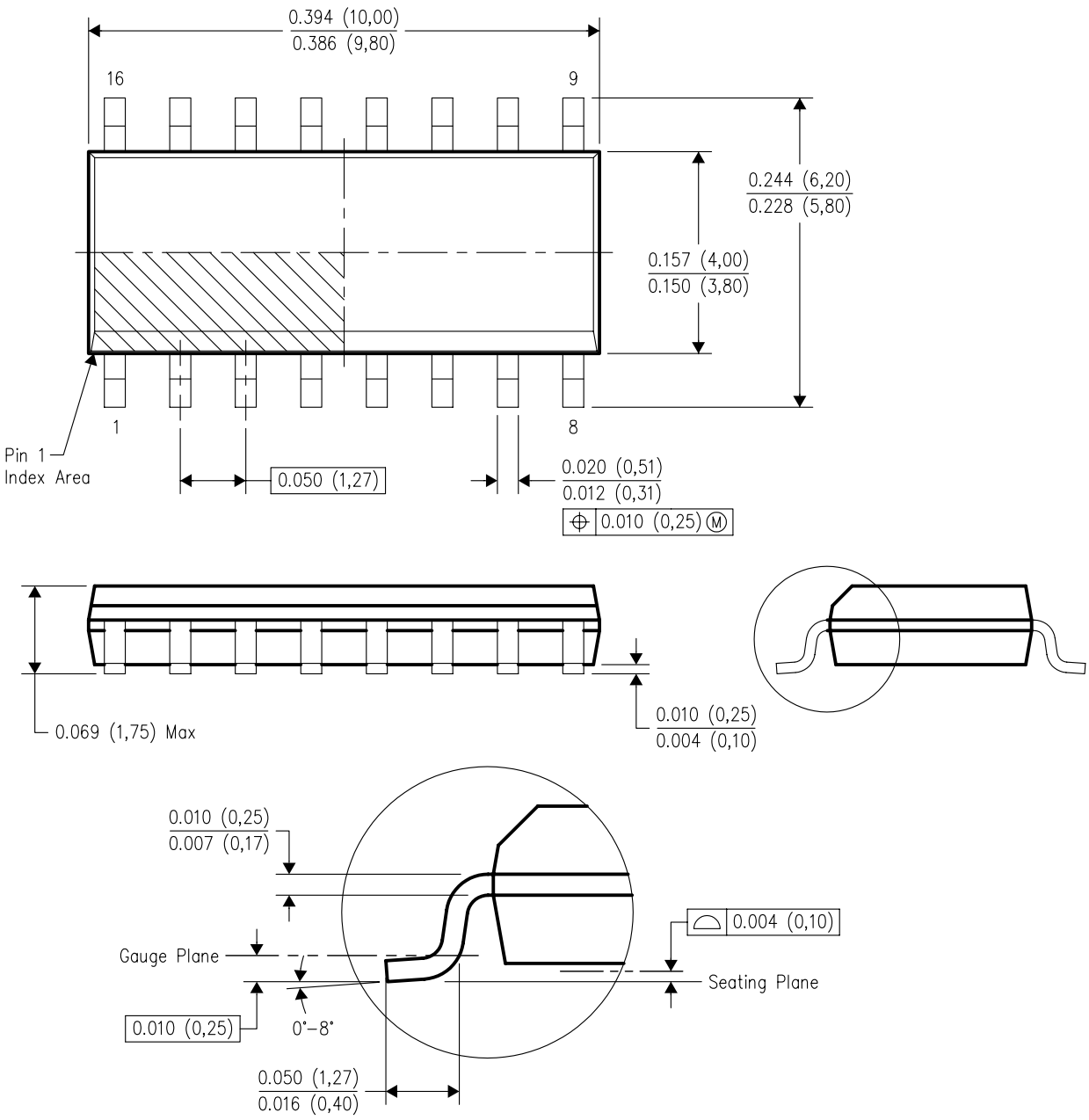
DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



4040049/E 12/2002

NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

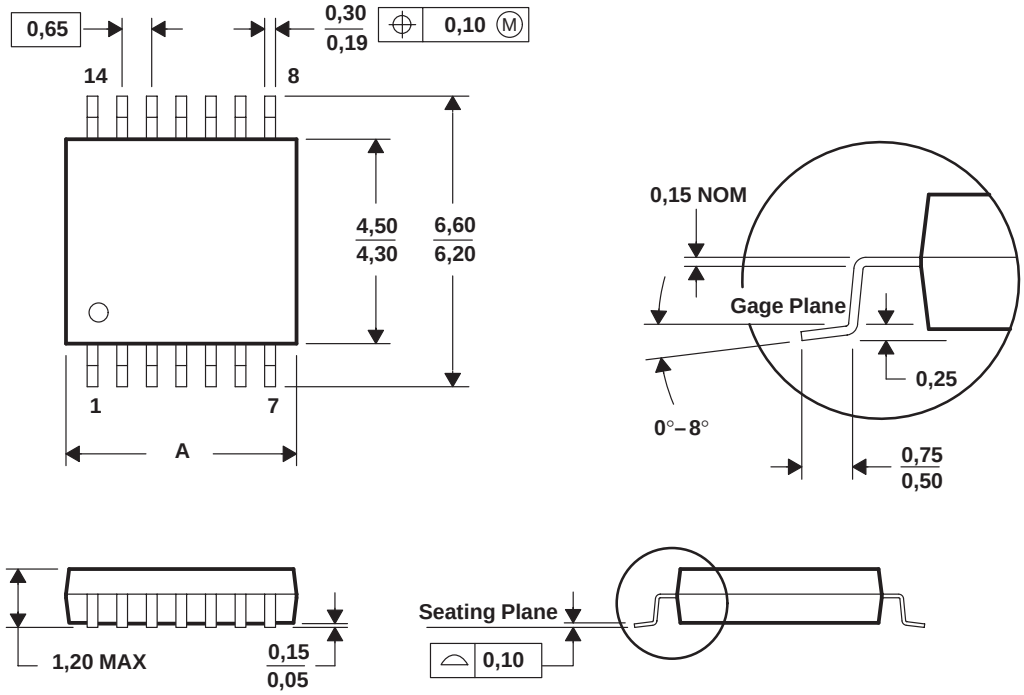
D (R–PDSO–G16) PLASTIC SMALL–OUTLINE PACKAGE



NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
D. Falls within JEDEC MS–012 variation AC.

PW (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14 PINS SHOWN



DIM \ PINS **	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/F 01/97

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

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